

## Lonten N-channel 600V, 7A Power MOSFET

### Description

The Power MOSFET is fabricated using the advanced planar VDMOS technology. The resulting device has low conduction resistance, superior switching performance and high avalanche energy.

### Features

- ◆ Low  $R_{DS(on)}$
- ◆ Low gate charge (typ.  $Q_g = 20.6\text{nC}$ )
- ◆ 100% UIS tested
- ◆ RoHS compliant

### Applications

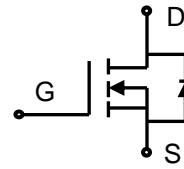
- ◆ Power factor correction.
- ◆ Switched mode power supplies.
- ◆ LED driver.

### Product Summary

$V_{DSS}$	600V
$I_D$	7A
$R_{DS(on),max}$	1.3Ω
$Q_{g,typ}$	20.6nC



TO-220    TO-220F



N-Channel MOSFET



### Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	600	V
Continuous drain current ( $T_C = 25^\circ\text{C}$ )	$I_D$	7	A
( $T_C = 100^\circ\text{C}$ )		4.2	A
Pulsed drain current <sup>1)</sup>	$I_{DM}$	28	A
Gate-Source voltage	$V_{GSS}$	$\pm 30$	V
Avalanche energy, single pulse <sup>2)</sup>	$E_{AS}$	405	mJ
Peak diode recovery $dv/dt$ <sup>3)</sup>	$dv/dt$	5	V/ns
Power Dissipation TO-220F ( $T_C = 25^\circ\text{C}$ )	$P_D$	39	W
Derate above $25^\circ\text{C}$		0.31	$\text{W}/^\circ\text{C}$
Power Dissipation		100	W
TO-220\ TO-251\ TO-252 ( $T_C = 25^\circ\text{C}$ )		0.8	$\text{W}/^\circ\text{C}$
Derate above $25^\circ\text{C}$			
Operating junction and storage temperature range	$T_J, T_{STG}$	-55 to +150	$^\circ\text{C}$
Continuous diode forward current	$I_S$	7	A
Diode pulse current	$I_{S,pulse}$	28	A

### Thermal Characteristics

Parameter	Symbol	Value		Unit
		TO-220F	TO-220\ TO-251\ TO-252	
Thermal resistance, Junction-to-case	$R_{\theta JC}$	3.2	1.25	$^\circ\text{C}/\text{W}$
Thermal resistance, Junction-to-ambient	$R_{\theta JA}$	62.5	110	$^\circ\text{C}/\text{W}$

## Package Marking and Ordering Information

Device	Device Package	Marking	Units/Tube	Units/Real
LNC7N60	TO-220	LNC7N60	50	
LND7N60	TO-220F	LND7N60	50	

## Electrical Characteristics

T<sub>c</sub> = 25°C unless otherwise noted

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
<b>Static characteristics</b>						
Drain-source breakdown voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0 V, I <sub>D</sub> =250 uA	600	-	-	V
Gate threshold voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250 uA	2	-	4	V
Drain cut-off current	I <sub>DSS</sub>	V <sub>DS</sub> =600 V, V <sub>GS</sub> =0 V, T <sub>j</sub> = 25°C T <sub>j</sub> = 125°C	-	-	1 100	μA
Gate leakage current, Forward	I <sub>GSSF</sub>	V <sub>GS</sub> =30 V, V <sub>DS</sub> =0 V	-	-	100	nA
Gate leakage current, Reverse	I <sub>GSSR</sub>	V <sub>GS</sub> =-30 V, V <sub>DS</sub> =0 V	-	-	-100	nA
Drain-source on-state resistance	R <sub>D(on)</sub>	V <sub>GS</sub> =10 V, I <sub>D</sub> =3.5 A	-	1.0	1.3	Ω
<b>Dynamic characteristics</b>						
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz	-	1112	-	pF
Output capacitance	C <sub>oss</sub>		-	90	-	
Reverse transfer capacitance	C <sub>rss</sub>		-	5	-	
Turn-on delay time	t <sub>d(on)</sub>	V <sub>DD</sub> = 300 V, I <sub>D</sub> = 7 A R <sub>G</sub> = 10 Ω, V <sub>GS</sub> =15 V	-	12	-	ns
Rise time	t <sub>r</sub>		-	30	-	
Turn-off delay time	t <sub>d(off)</sub>		-	52	-	
Fall time	t <sub>f</sub>		-	12	-	
<b>Gate charge characteristics</b>						
Gate to source charge	Q <sub>gs</sub>	V <sub>DD</sub> =480 V, I <sub>D</sub> =7 A, V <sub>GS</sub> =0 to 10 V	-	5.4	-	nC
Gate to drain charge	Q <sub>gd</sub>		-	7.4	-	
Gate charge total	Q <sub>g</sub>		-	20.6	-	
Gate plateau voltage	V <sub>plateau</sub>		-	5.1	-	V
<b>Reverse diode characteristics</b>						
Diode forward voltage	V <sub>SD</sub>	V <sub>GS</sub> =0 V, I <sub>F</sub> =7 A	-	-	1.5	V
Reverse recovery time	t <sub>r</sub>	V <sub>R</sub> =300 V, I <sub>F</sub> =7 A, dI <sub>F</sub> /dt=100 A/μs	-	306	-	ns
Reverse recovery charge	Q <sub>rr</sub>		-	2.1	-	μC
Peak reverse recovery current	I <sub>rrm</sub>		-	13.7	-	A

### Notes:

1. Pulse width limited by maximum junction temperature.
2. L=10mH, I<sub>AS</sub> = 9A, V<sub>DD</sub> =60V, Starting T<sub>j</sub>= 25°C.
3. I<sub>SD</sub> = 7A, di/dt≤100A/us, V<sub>DD</sub>≤BV<sub>DS</sub>, Starting T<sub>j</sub>= 25°C.

## Electrical Characteristics Diagrams

Figure 1. Typical Output Characteristics

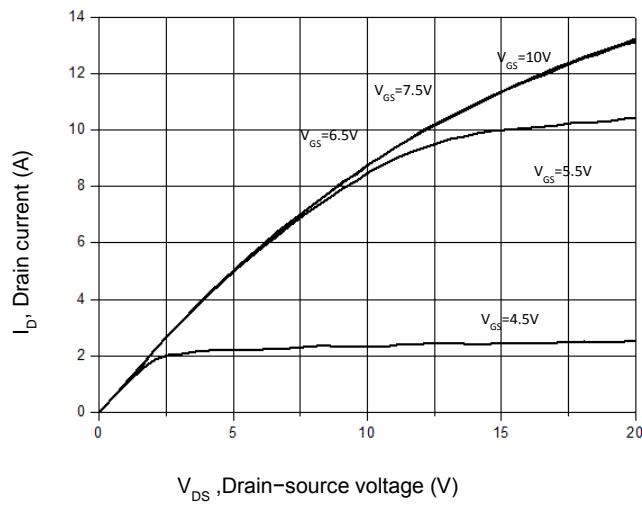


Figure 3. On-Resistance Variation vs. Drain Current

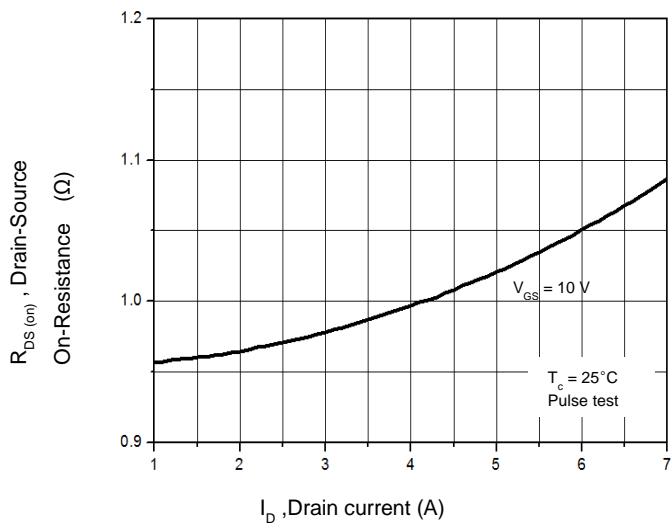


Figure 5. Breakdown Voltage vs. Temperature

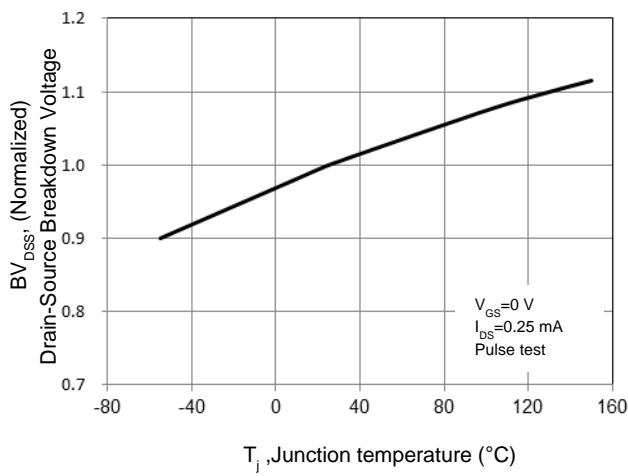


Figure 2. Transfer Characteristics

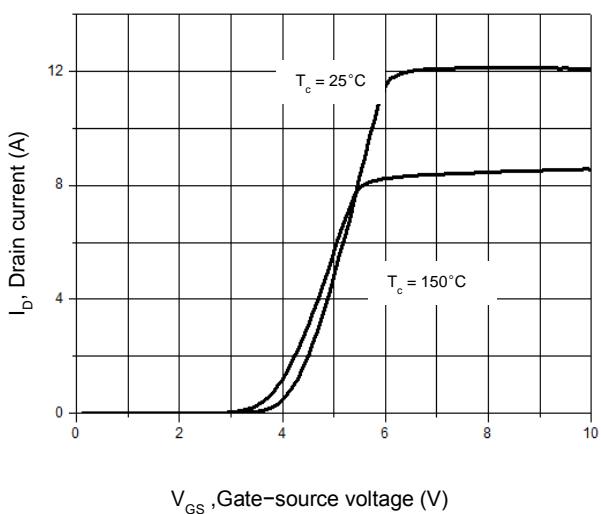


Figure 4. Threshold Voltage vs. Temperature

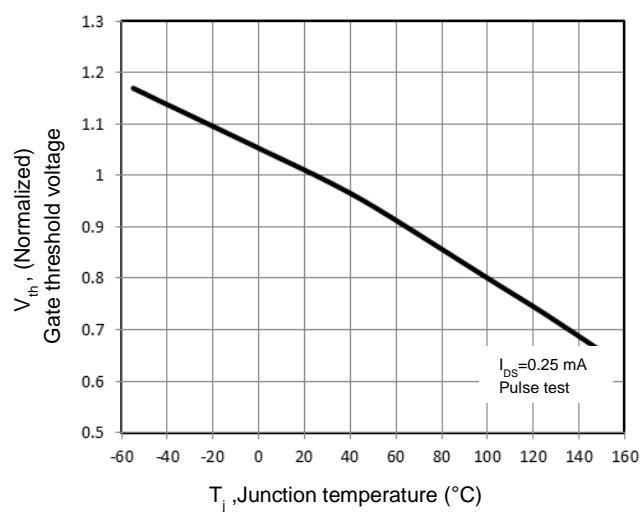


Figure 6. On-Resistance vs. Temperature

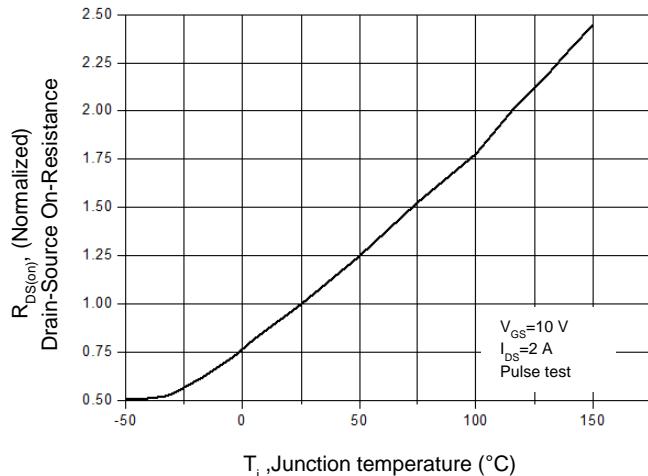


Figure 7. Capacitance Characteristics

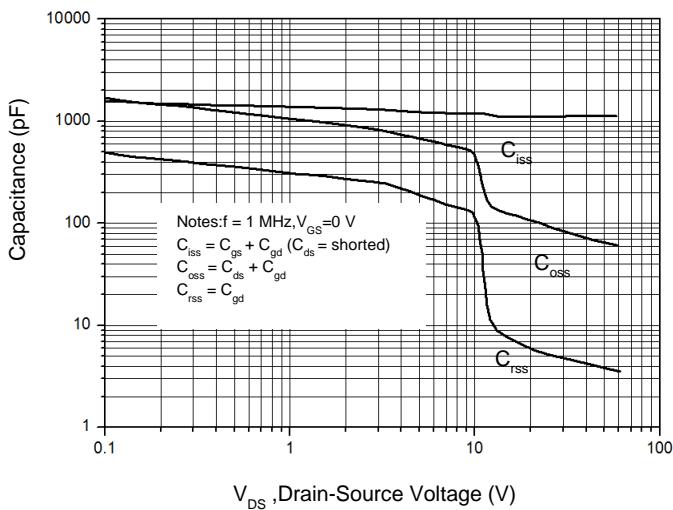


Figure 9. Maximum Safe Operating Area

TO-220F

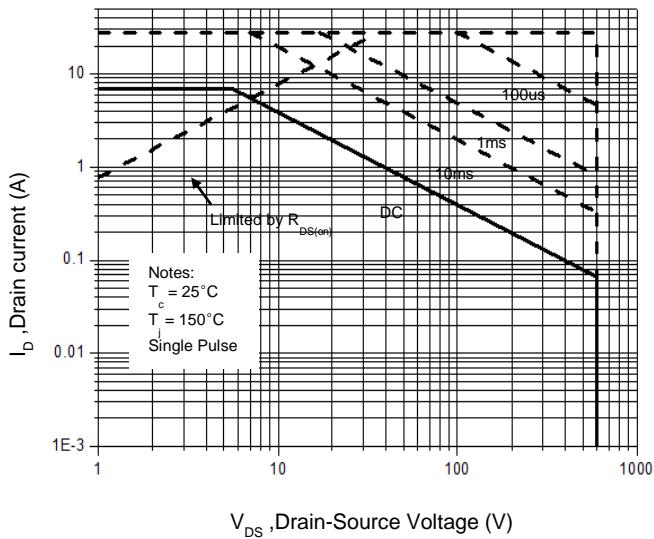


Figure 11. Power Dissipation vs. Temperature

TO-220F

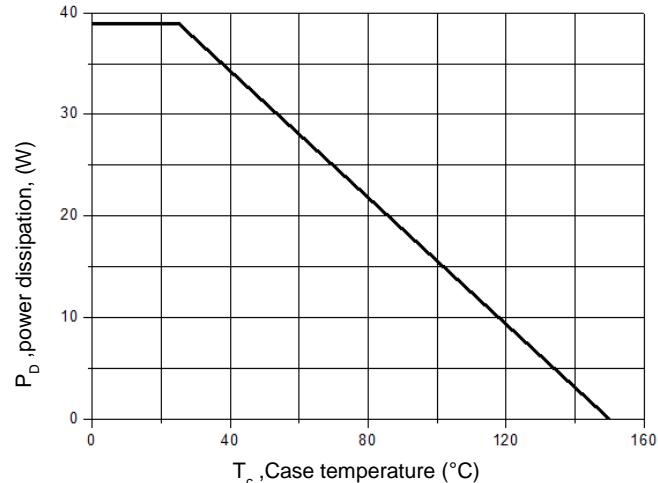


Figure 8. Gate Charge Characterist

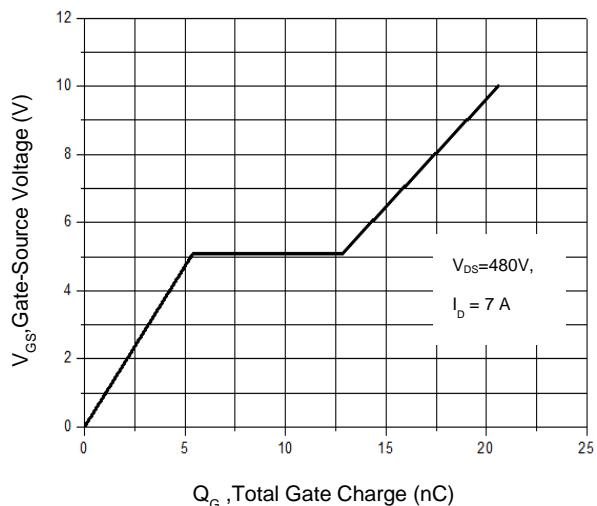


Figure 10. Maximum Safe Operating Area

TO-220/ TO-251/TO-252

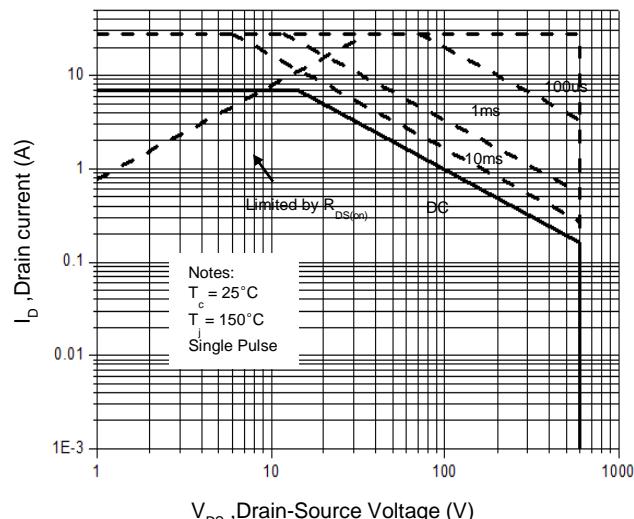


Figure 12. Power Dissipation vs. Temperature

TO-220/ TO-251/TO-252

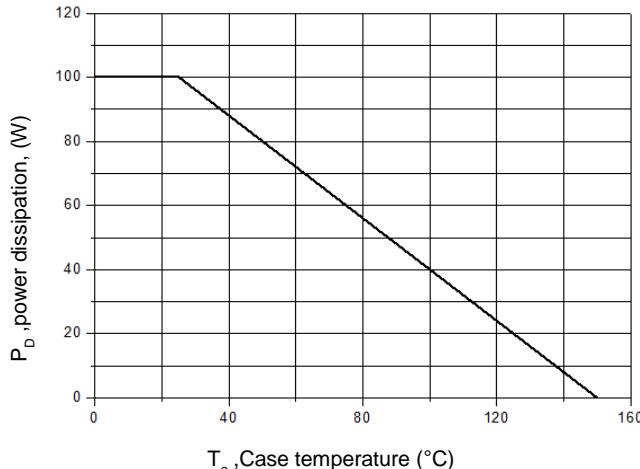


Figure 13. Continuous Drain Current vs. Temperature

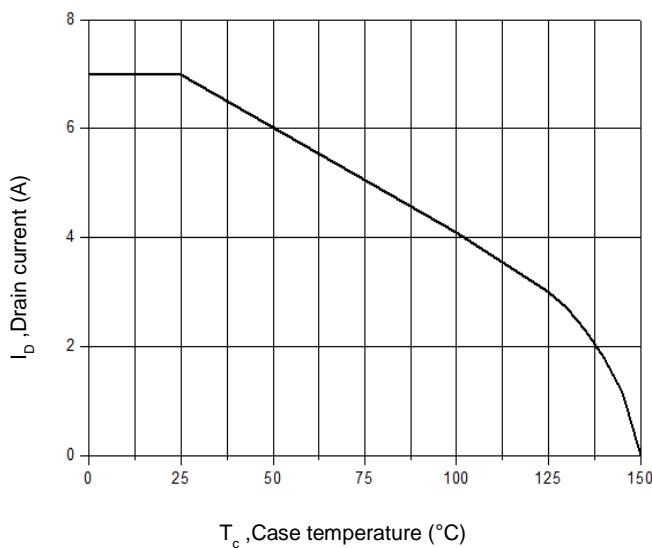


Figure 14. Body Diode Transfer Characteristics

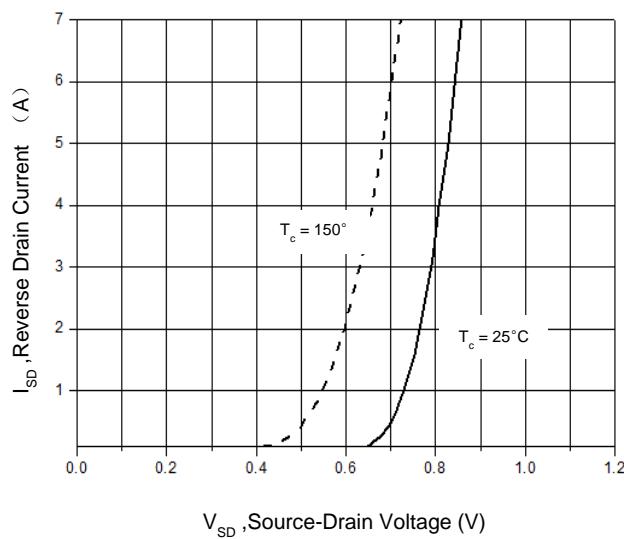


Figure 15 Transient Thermal Impedance,Junction to Case, TO-220F

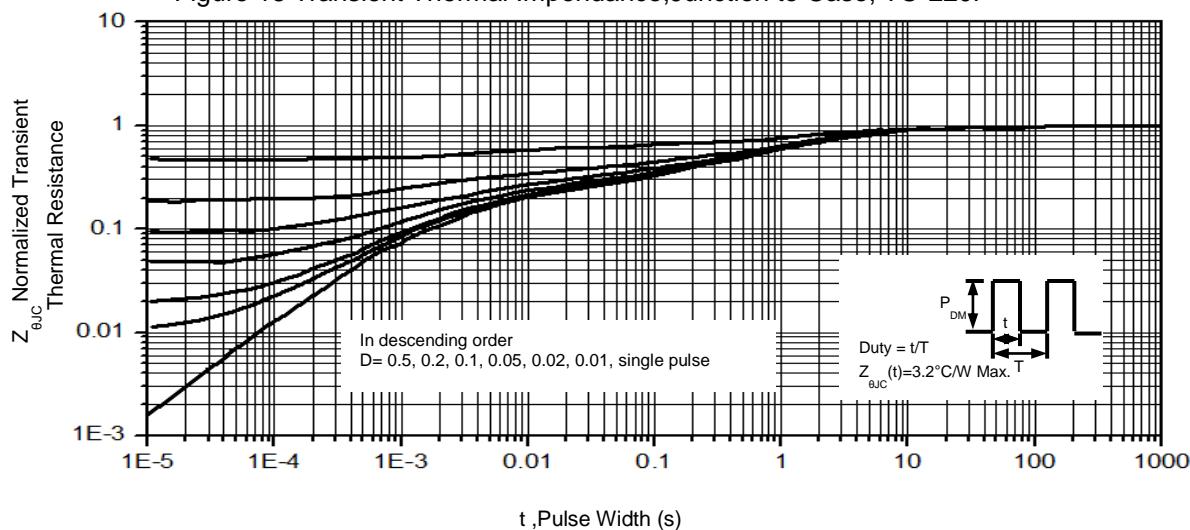
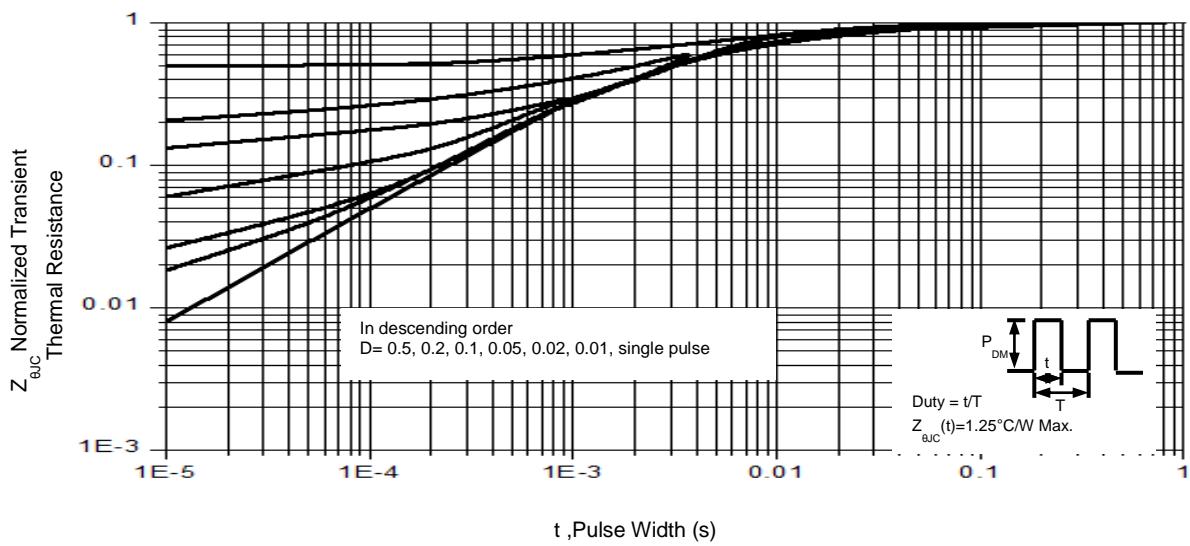
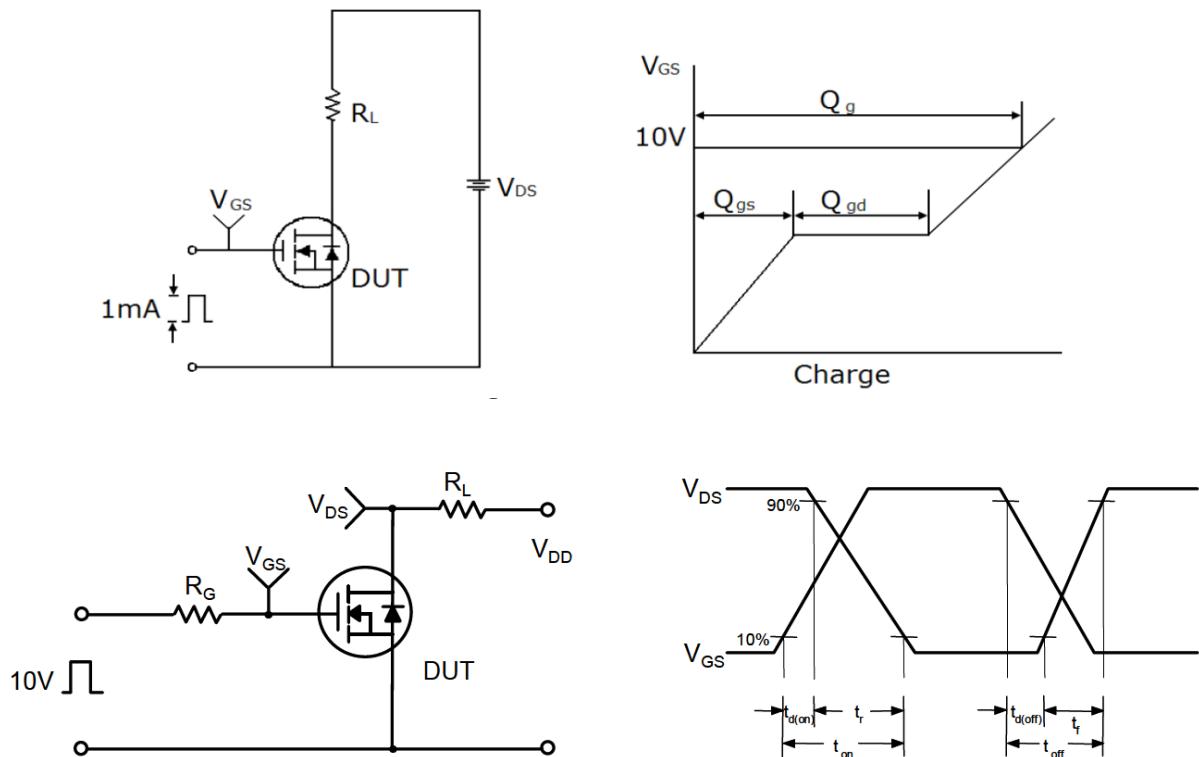


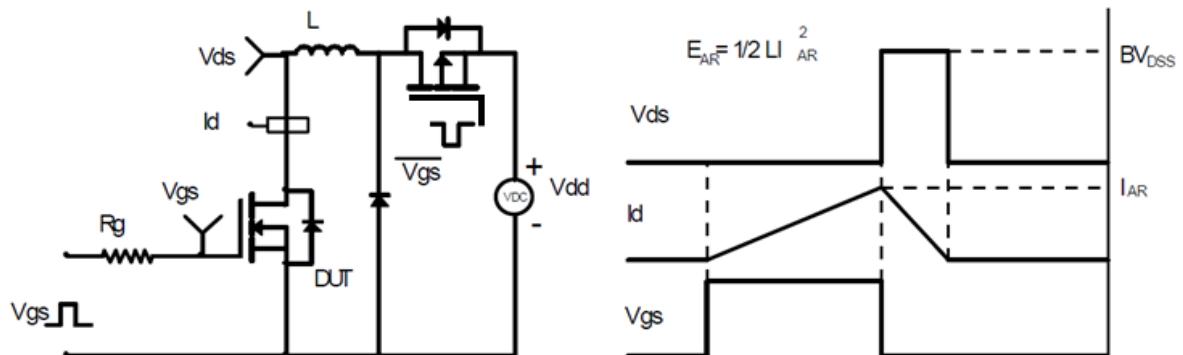
Figure 16. Transient Thermal Impedance,Junction to Case, TO-220/ TO-251/TO-252



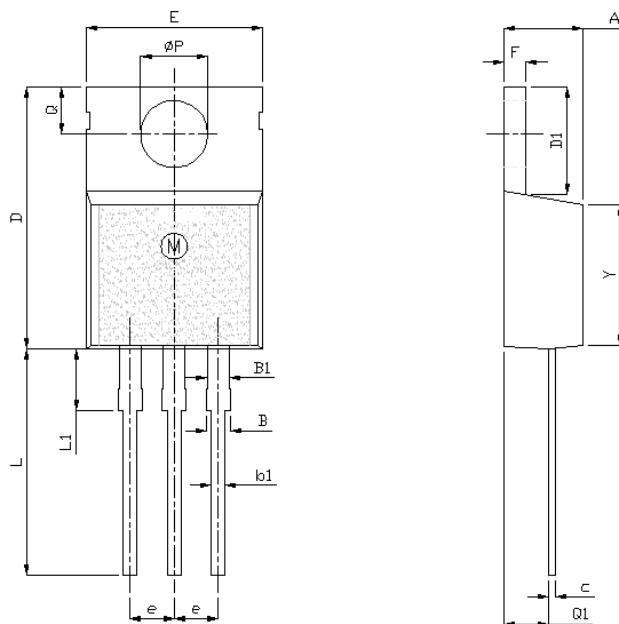
### Gate Charge Test Circuit & Waveform



### Unclamped Inductive Switching Test Circuit & Waveforms



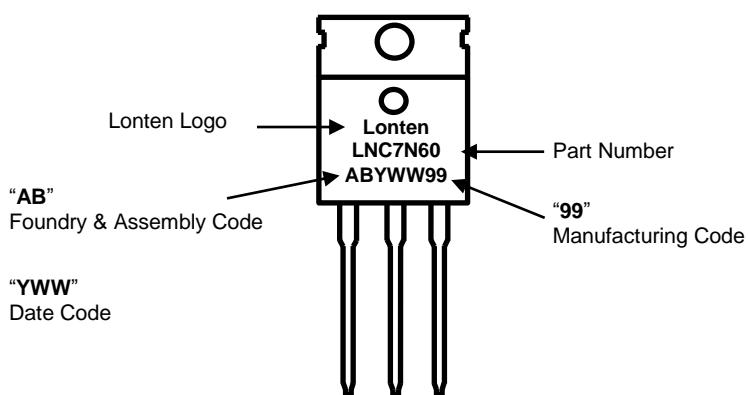
### Mechanical Dimensions for TO-220



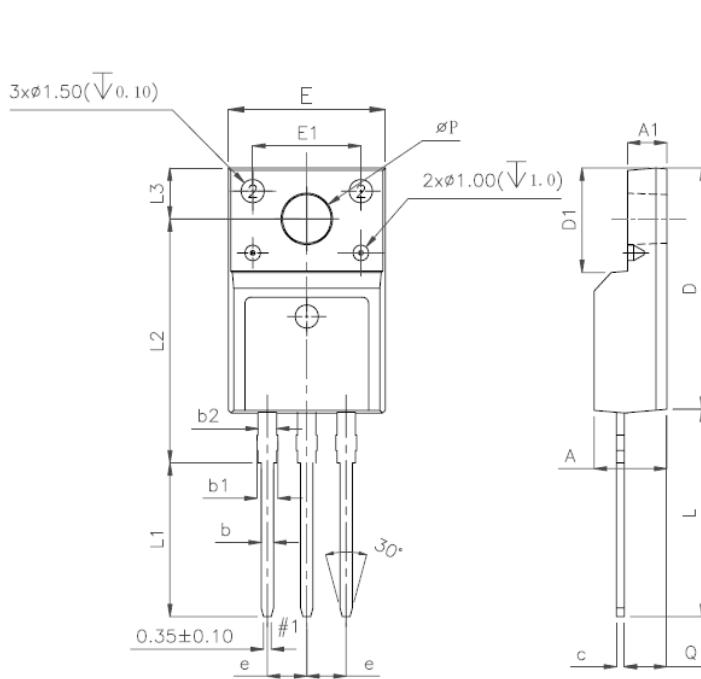
UNIT: mm

SYMBOL	MIN	NOM	MAX
A	4		4.8
B	1.2		1.4
B1	1		1.4
b1	0.75		0.95
c	0.4		0.55
D	15		16.5
D1	5.9		6.9
E	9.9		10.7
e	2.44	2.54	2.64
F	1.1		1.4
L	12.5		14.5
L1	3	3.5	4
φP	3.7	3.8	3.9
Q	2.5		3
Q1	2		2.9
Y	8.02	8.12	8.22

### TO-220 Part Marking Information

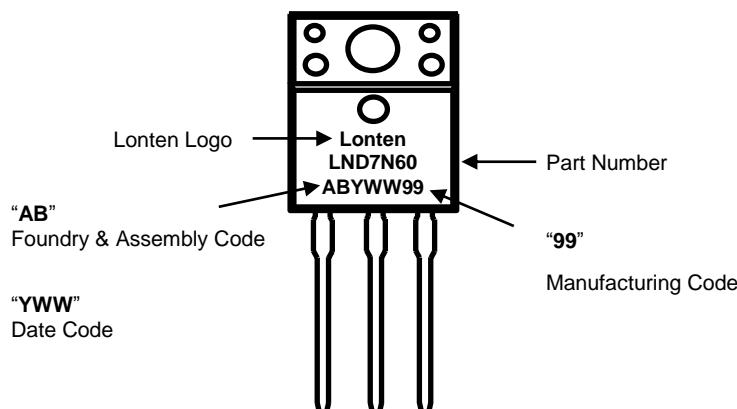


### Mechanical Dimensions for TO-220F



UNIT: mm			
SYMBOL	MIN	NOM	MAX
A	4.5		4.9
A1	2.3		2.9
b	0.65		0.9
b1	1.1		1.7
b2	1.2		1.4
c	0.35		0.65
D	14.5		16.5
D1	6.1		6.9
E	9.6		10.3
E1	6.5	7	7.5
e	2.44	2.54	2.64
L	12.5		14.3
L1	9.45		10.05
L2	15		16
L3	3.2		4.4
ΦP	3		3.3
Q	2.5		2.9

### TO-220F Part Marking Information



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